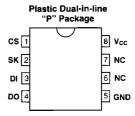


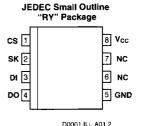
# 256-Bit Serial Electrically Erasable PROM with 2V Read Capability

#### **FEATURES**

- 4.5 to 5.5V Operation
- Extended Temperature Range: -40°C to +85°C
- State-of-the-Art Architecture
  - Nonvolatile data storage
  - Single supply 5V operation
  - Fully TTL compatible inputs and outputs
  - Auto increment for efficient data dump
  - 1MHz operation
- · Hardware and Software Write Protection
  - Defaults to write-disabled state at power up
  - Software instructions for write-enable/disable
  - VCC lockout inadvertent write protection
- Low Power Consumption
  - 1mA active
  - 1µA standby
- Low Voltage Read Operations
  - Reliable read operations down to 2.0 volts
- Advanced Low Voltage CMOS E<sup>2</sup>PROM Technology
- · Versatile, Easy-to-Use Interface
  - Self-timed programming cycle
  - Automatic erase-before-write
  - Programming Status Indicator
  - Word and chip erasable
- Durable and Reliable
  - 100-year data retention after 100K write cycles
  - Minimum of 100,000 erase/write cycles
  - Unlimited read cycles
  - ESD protection

## **PIN CONFIGURATIONS**





#### **PIN NAMES**

CS Chip Select
SK Serial Data Clock
DI Serial Data Input
DO Serial Data Output
GND Ground
VCC Power Supply
NC Not Connected

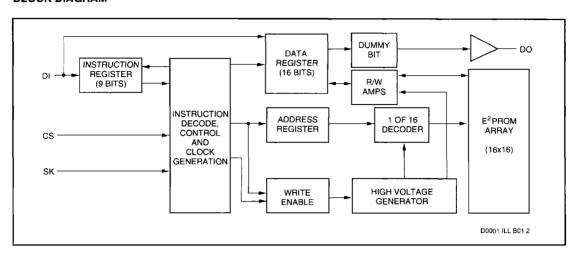
## **OVERVIEW**

The XL93LC06A is a cost effective 256-bit, nonvolatile, serial E²PROM. It is fabricated using EXEL's advanced CMOS E²PROM technology. The XL93LC06A provides efficient nonvolatile read/write memory arranged as 16 registers of 16 bits each. Seven 9-bit instructions control the operation of the device, which include read, write, and mode enable functions. The data output pin (DO) indicates the status of the device during the self-timed nonvolatile programming cycle.

The self-timed write cycle includes an automatic erase-before-write capability. To protect against inadvertent writes, the WRITE instruction is accepted only while the chip is in the write enabled state. Data is written in 16 bits per write instruction into the selected register. If Chip Select (CS) is brought HIGH after initiation of the write cycle, the Data Output (DO) pin will indicate the READY/BUSY status of the chip.



#### **BLOCK DIAGRAM**



#### **APPLICATIONS**

The XL93LC06A is ideal for high volume applications requiring low power and low density storage. This device uses a cost effective, space saving 8-pin package. Candidate applications include robotics, alarm devices, electronic locks, meters and instrumentation settings.

#### **ENDURANCE AND DATA RETENTION**

The XL93LC06A is designed for applications requiring up to 100,000 erase/write cycles. It provides 100 years of secure data retention without power after the execution of 100,000 write cycles.

#### **DEVICE OPERATION**

The XL93LC06A is controlled by seven 9-bit instructions. Instructions are clocked in (serially) on the DI pin. Each instruction begins with a logical "1" (the start bit). This is followed by the opcode (2 bits), the address field (6 bits), and data, if appropriate. The clock signal (SK) may be halted at any time and the XL93LC06A will remain in its last state. This allows full static flexibility and maximum power conservation.

#### Read (READ)

The READ instruction is the only instruction that results in serial data on the DO pin. After the read instruction and address have been decoded, data is transferred from the selected memory register into a 16-bit serial shift register. (Please note that one logical "0" bit precedes the actual 16-bit output data string.) The output on DO changes during the LOW-TO-HIGH transitions of SK. (See Figure 2.)

## Low Voltage Read

The XL93LC06A has been designed to ensure that data read operations are reliable in low voltage environments. The XL93LC06A is guaranteed to provide accurate data during read operations with  $V_{\rm CC}$  as low as 2.0V.

#### **Auto Increment Read Operations**

In order to facilitate memory transfer operations, the XL93LC06A has been designed to output a continuous stream of memory content in response to a single read operation instruction. To utilize this function, the system asserts a read instruction specifying a start location address. Once the 16 bits of the addressed word have been clocked out, the data in consecutively higher address locations is output. The address will wrap around with CS HIGH until the Chip Select control pin is brought LOW. This allows for single instruction data dumps to be executed with a minimum of firmware overhead.

## Write Enable (WEN)

The write enable (WEN) instruction must be executed before any device programming can be done. When  $V_{\rm CC}$  is applied, this device powers up in the write disabled state. The device then remains in a write disabled state until a WEN instruction is executed. Thereafter the device remains enabled until a WDS instruction is executed or until  $V_{\rm CC}$  is removed. (NOTE: Neither the WEN nor the WDS instruction has any effect on the READ instruction. See Figure 3.)



## Write (WRITE)

The WRITE instruction includes 16 bits of data to be written into the specified register. After the last data bit has been clocked into DI, and before the next rising edge of SK, CS must be brought LOW. The falling edge of CS initiates the self-timed programming cycle.

After a minimum wait of 250ns from the falling edge of CS (tcs), if CS is brought HIGH, DO will indicate the READY/BUSY status of the chip: logical "0" means programming is still in progress; logical "1" means the selected register has been written, and the part is ready for another instruction. (See Figure 4.) (NOTE: The combination of CS HIGH, DI HIGH and the rising edge of the SK clock, resets the READY/BUSY flag. Therefore, it is important not to reset the READY/BUSY flag through this combination of control signals, if you want to access it.) Before a WRITE instruction can be executed, the device must be write enabled (see WEN).

### Write All (WRALL)

The write all (WRALL) instruction programs all registers with the data pattern specified in the instruction.

As with the WRITE instruction, if CS is brought HIGH after a minimum wait of 250ns (t<sub>CS</sub>), the DO pin indicates the READY/BUSY status of the chip. (See Figure 5.)

#### Write Disable (WDS)

The write disable (WDS) instruction disables all programming capabilities. This protects the entire memory array against accidental modification of data until a WEN instruction is executed. (When  $V_{CC}$  is applied, this part powers up in the write-disabled state.) To protect data, a WDS instruction should be executed upon completion of each programming operation. (NOTE: Neither the WEN nor the WDS instruction has any effect on the READ instruction.) (See Figure 6.)

#### Erase

The Erase instruction (ERASE) programs the addressed memory location to all "1s." Once the address is clocked in, the falling edge of CS will initiate the internal programming cycle. After waiting a minimum 250ns, the READY/BUSY status can be monitored on DO.

## Erase All (ERAL)

Full chip erase is provided for ease of programming. Erasing the entire chip involves setting all bits in the entire memory array to a logical "1." (See Figure 8.)

## **V<sub>CC</sub> Lockout - Inadvertent Write Protection**

To ensure against inadvertent write operations, the XL93LC06A has been equipped with an internal  $V_{\rm CC}$  sensor circuit which inhibits data alteration when the supply voltage ( $V_{\rm CC}$ ) falls below  $V_{\rm Wi}$ . If the applied  $V_{\rm CC}$  is below 3.75V (typical), the XL93LC06A is inhibited from executing write operations thereby protecting the non-volatile data from inadvertent write operations.

#### INSTRUCTION SET

Instruction	Start Bit	OP Code	Address	Input Data
READ	1	10	XX(A3-A0)	
WEN (Write Enable)	1	00	11XXXX	
WRITE	1	01	XX(A3-A0)	D <sub>15</sub> -D <sub>0</sub>
WRALL (Write All Registers)	1	00	01XXXX	D <sub>15</sub> -D <sub>0</sub>
WDS (Write Disable)	1	00	00XXXX	
ERASE	1	11	XX(A3-A0)	
ERAL (Erase All Registers)	1	00	10XXXX	

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## **ABSOLUTE MAXIMUM RATINGS**

Temperature Under Bias:	40°C to +85°C
Storage Temperature	65°C to +150°C
Lead Soldering Temperature (less than 10 seconds)	300°C
Supply Voltage	0 to 6.5V
Voltage on Any Pin	0.3 to Vcc + 0.3V
ESD Rating	2000V
NOTE: These are STRESS ratings only. Appropriate conditions for operating these devices are given elsewh beyond those listed here may permanently damage the part. Prolonged exposure to maximum ratings may ac	

# DC ELECTRICAL CHARACTERISTICS

TA =-40°C to +85°C

Symbol Parameter		Conditions	Vcc = 5V ± 10%		Vcc=2.0V (Read only)		Units
Зуньог	ratameter	Conditions	Min	Max	Min	Max	Units
ICC1	Operating Current CMOS Input Levels	CS = V <sub>CC</sub> , SK = 1MHz @ 5V SK = 250KHz @ 2V		2		2	mA
ICC2	Operating Current TTL Input Levels	CS = V <sub>1</sub> H, SK = 1MHz		5		n/a	mA
ISB	Standby Current (CMOS)	CS = DI = SK =0V		2		2	μА
ILI	Input Leakage	VIN = 0V to VCC, CS, SK, DI		1		1	μА
ILO	Output Leakage	VOUT = 0V to VCC, CS = 0V		1		1	μА
VIL	Input Low Voltage		-0.1	0.8	-0.1	0.1 VCC	٧
VIH	Input High Voltage		2	Vcc + 0.2	0.9 VCC	Vcc + 0.2	٧
VOL1	Output Low Voltage	ioL = 2.1mA TTL		0.4		n/a	٧
VOH1	Output High Voltage	IOH = -400μA TTL	2.4		n/a		٧
VOL2	Output Low Voltage	IOL = 10μA CMOS		0.2		0.2	٧
VoH2	Output High Voltage	IOH = -10μA CMOS	Vcc-0.2		VCC - 0.2		٧
Vwi	Write Inhibit Threshold		2.7	4.4	n/a	n/a	V

# **AC ELECTRICAL CHARACTERISTICS**

TA =-40°C to +85°C

		Conditions	Vcc = 5V ± 10%		Vcc=2.0V (Read only)		11-14-
Symbol	Parameter		Min	Max	Min	Max	Units
fsk	SK Clock Frequency	:	0	1000	0	250	KHz
tskH	SK High Time		400		2000		ns
tskl	SK Low Time		250		2000		ns
tcs	Minimum CS Low Time		250		1000		ns
tcss	CS Setup Time	Relative to SK	50		200		ns
tDIS	DI Setup Time	Relative to SK	100		400		ns
tcsh	CS Hold Time	Relative to SK ~	0		0		ns
tDIH	DI Hold Time	Relative to SK	100		400		ns
tPD1	Output Delay to "1"	AC Test		500		2000	ns
tPD0	Output Delay to "0"	AC Test		500		2000	ns
tsv	CS to Status Valid	AC Test C <sub>L</sub> = 100pF		500		2000	ns
tDF	CS to DO in 3-state	CS = Low to DO = Hi-Z		100		400	ns
twp	Write Cycle Time	CS = Low to DO = Ready		10		n/a	ms

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# **CAPACITANCE**

 $T_A = 25^{\circ}C, f = 250KHz$ 

Symbol	Parameter	Max	Units
Cin	Input Capacitance	5	ρF
Соит	Output Capacitance	5	pF

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